Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,996	CHUN, CHANG-HYEN	
Examiner	Art Unit	
Pierre-Louis Desir	2681	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
455	442	6/11/2005	PD
455	436	6/11/2005	PD
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST	6/11/2005	PD			
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